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[IL/IL]; 27/A Hasiday Umot HaOlam Street, 32985 Haifa (IL). **KARASIKOV, Nir** [IL/IL]; 49 Hague Street, 34980 Haifa (IL).

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(74) Agents: **LUZZATTO, Kfir** et al.; P.O. Box 5352, 84152 Beer Sheva (IL).

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(71) Applicant (for all designated States except US): **P.M.L - PARTICLES MONITORING TECHNOLOGIES LTD.** [IL/IL]; Kinarot Technological Incubator, 15132 Emek Ha-Yarden (IL).

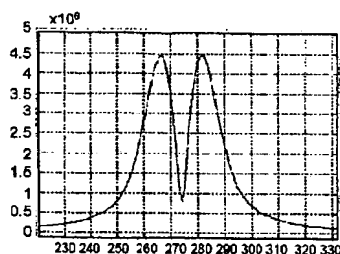
(72) Inventors; and

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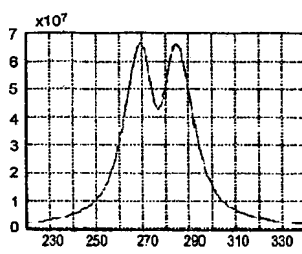
(75) Inventors/Applicants (for US only): **SHAMIR, Joseph**

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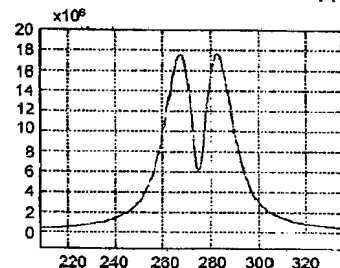
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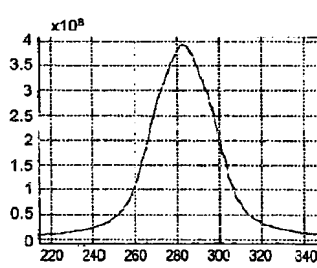
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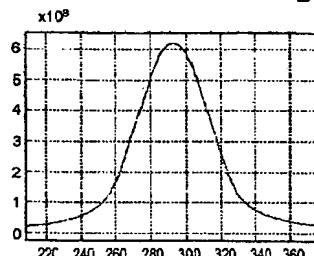
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(57) Abstract: The present invention provides method of particle size and concentration measurement that comprises the steps of: providing a focused, synthesized, non-Gaussian laser beam, causing the beam to interact with the particles, measuring the interaction signal and the number of interactions per unit time of the beam with the particles, and using algorithms to map the interaction signals to the particle size and the number of interactions per unit time to the concentration. The particles are fluid borne, airborne, or on a surface and have a size ranging from sub-micron to thousands of microns. In a preferred embodiment of the invention, the focused, synthesized, non-Gaussian laser beam is a dark beam. The non-Gaussian beam can be generated by employing a mask over a Gaussian laser beam or by directly modifying the laser cavity or by combining the beams from several lasers. The measurements can be made using the duration of interaction with a scanning beam, including dark field. The invention further provides a system for particle size and concentration measurement.



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